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Identifying efficiency-loss pathways in triplet–triplet annihilation upconversion systems†

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Triplet–triplet annihilation upconversion (TTA-UC) systems have been studied extensively recently, and have been proposed for use in a wide range of applications. Identification of the dominant mechanisms of upconversion-efficiency loss (UEL) will assist in the development of efficient TTA-UC systems. In this work, we combine experiments and kinetic analysis to study UEL. We identify exciplex formation and reverse triplet energy transfer (TET) as the two most important UEL mechanisms in the model TTA-UC system of platinum octaethylporphyrin (PtOEP) and 9,10-diphenylanthracene (DPA). Based on spectral analysis and time-resolved photoluminescence experiments, we show that exciplex formation is a potent UEL pathway in the PtOEP–DPA system. We demonstrate that prolonged sensitizer phosphorescence arises from reverse TET from annihilator triplet states, and that the reverse TET is likely facilitated by thermal population of low-frequency vibrational states in the sensitizer and the annihilator. Additionally, we demonstrate how the rate constants for reverse TET and exciplex formation can be estimated based on knowledge of a few key parameters and the experimental value of the optimum sensitizer concentration.

Introduction

Triplet–triplet annihilation upconversion (TTA-UC) is a process in which two annihilator triplet states that were created *via* triplet energy transfer (TET) from photogenerated sensitizer triplet states undergo disproportionation to produce an annihilator in a fluorescent singlet state and an annihilator in the ground electronic state. TTA-UC does not require high excitation powers to achieve frequency upconversion,^{1–3} and can even be driven by an incoherent light source, such as a light-emitting diode (LED).^{4–7} TTA-UC is being pursued for a variety of applications, such as bioimaging,^{3,8–10} solar-cell performance enhancement,^{11–15} and organic LEDs.^{16–19} A kinetic analysis of the TTA-UC process indicates that the intensity of the upconverted light depends quadratically on irradiance under conditions in which unimolecular annihilator triplet-decay processes are favored over the bimolecular TTA process.^{20–22} In the converse situation, the intensity of the upconverted light depends linearly on the irradiance. The irradiance at which the quadratic

and linear regimes meet is commonly referred to as the threshold irradiance (I_{th}).²³ A higher sensitizer concentration increases the concentration of photogenerated sensitizer triplet states, thereby decreasing I_{th} . A smaller I_{th} is generally desirable, and is indicative of a TTA-UC system that performs efficiently at low irradiances. However, increasing the concentration of sensitizers has been observed to be deleterious to both the upconverted fluorescence intensity and the upconversion quantum yield.^{24,25} Sensitizer TTA, which results in the net loss of one sensitizer triplet for every two that are photogenerated, is one suspected culprit in the decrease of the upconversion quantum yield with increasing sensitizer concentration.^{26,27} However, for ideal TTA-UC systems, sensitizer TTA is often outcompeted by TET to the annihilator, and so sensitizer TTA may not be the sole driver behind the upconversion efficiency loss (UEL) that arises at high sensitizer concentrations. Back energy transfer from the emissive annihilator singlet states to the sensitizer, *via* long-range energy-transfer mechanisms such as Förster resonance energy transfer (FRET), has also been identified as a UEL mechanism that has the potential to become more important at high sensitizer concentrations.^{28,29}

Isokuortii *et al.* studied the effects of reverse TET, *i.e.*, from the annihilator triplet state to the sensitizer, in cases in which the annihilator triplet energy was lower than, or slightly higher than, the sensitizer triplet energy.³⁰ These authors found that for an endothermic system in which the triplet energy of the annihilator was ~ 0.08 eV lower than the triplet energy of the sensitizer, the rate constant for reverse TET from the annihilator to the sensitizer was twenty times larger than that for forward TET to the annihilator. A key finding of Isokuortii *et al.*

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is that even for a system in which the difference between the sensitizer triplet energy and the annihilator triplet energy is several times larger than the thermal energy, reverse TET can be the dominant annihilator triplet decay pathway at low irradiances. As discussed below, we believe that low-frequency vibrational modes are a key consideration in this phenomenon.

Efforts to reduce efficiency losses in the TTA-UC process, for example by minimizing the energy difference between the singlet and triplet states of the sensitizer,^{31–33} or by minimizing the energy difference between the annihilator and sensitizer triplet states,^{34,35} may inadvertently lead to UEL due to increased rate of reverse intersystem crossing (RISC) in the sensitizer in the first case, and of reverse TET in the second case. There have been numerous studies on photochemical upconversion systems in which the effect of reverse TET is manifested in the form of long-lived sensitizer emission.^{36–38} Meroni *et al.* note, in a study of a TTA-UC system comprising Pd(II) *meso*-tetraphenyl tetrabenzoporphine and perylene,³⁸ that the lifetimes of the annihilator triplets and of the delayed phosphorescence that arises due to reverse TET must be equal. These authors concluded that an increase in the concentration of annihilators suppresses the effects of reverse TET, and increases the lifetime of upconverted emission. Although Meroni *et al.* did not study the effects of an increase in the sensitizer concentration, presumably such an increase would induce the opposite effect, *i.e.*, enhancing the effects of reverse TET and reducing the lifetime of the upconverted emission.

Gholizadeh *et al.* reported the sensitizer-concentration-dependent quenching of annihilator triplets, a process they termed “dynamic quenching.”²⁴ These authors discovered that for a TTA-UC system consisting of platinum octaethylporphyrin (PtOEP) and diphenylanthracene (DPA), the dynamic quenching rate constant was $4.6 \times 10^6 \text{ M}^{-1} \text{ s}^{-1}$, roughly four orders of magnitude larger than the rate of intrinsic annihilator decay. Spin-orbit coupling (SOC) induced in the annihilator by the heavy central atoms common in photosensitizers, which is known as the heavy-atom effect,^{39,40} is one possible origin of dynamic quenching. However, Gholizadeh *et al.* showed that the addition of a bromine-containing compound to a solution containing PtOEP and DPA did not affect the upconverted fluorescence intensity significantly. These authors also reported an increase in the empirically determined rate of dynamic quenching upon the replacement of the platinum in PtOEP with zinc, a lighter element. An important distinction between ZnOEP and PtOEP is that the triplet energy of the former (1.78 eV) is closer to that of the annihilator, DPA (1.77 eV), than is the triplet energy of the former.⁴¹ Therefore, reverse TET may also affect the apparent rate of dynamic quenching when ZnOEP is the sensitizer. The work of Gholizadeh *et al.* demonstrates that the heavy-atom effect cannot be the sole origin of dynamic quenching.

Although a large body of work has been dedicated to exploring UEL mechanisms on an individual basis, we are not aware of any concerted effort to analyze the potentially important UEL mechanisms with a mass-conserving kinetic model. A mass-conserving TTA-UC model accounts accurately for the steady-state concentration of ground-state molecules that can participate in various

UEL processes.⁴² Therefore, it would be beneficial to use such a model to analyze UEL mechanisms that are driven by interactions between ground-state and excited molecules at high irradiances. Here we perform such an analysis of mechanisms whereby an increase in the concentration of sensitizers hinders the upconversion ability of a TTA-UC system. Using PtOEP and DPA as a benchmark TTA-UC system, we also performed steady-state and time-resolved TTA-UC measurements. Based on the results of these experiments, we explore a range of UEL pathways, and use our kinetic model to determine which of these UEL mechanisms are the most influential. We employ the ratio of the sensitizer phosphorescence intensity to the upconverted fluorescence intensity, a quantity that we term the emission ratio, to identify UEL mechanisms that reduce the upconverted fluorescence intensity at steady state, while either not affecting, or even enhancing, the amount of sensitizer phosphorescence. We also use our kinetic model to analyze the effects of reverse TET on the upconversion quantum yield, the sensitizer emission decay, and the annihilator triplet lifetime. We demonstrate how reverse TET can affect the rate of dynamic quenching, as determined from the dependence of the rate of annihilator triplet decay on the sensitizer concentration. We show how the balance between enhanced upconverted emission due to an increase in sensitizer triplet concentration on the one hand, and enhanced rates of reverse TET and dynamic quenching due to a high concentration of sensitizers on the other hand, is affected by the rate constants for the latter two processes. Finally, we demonstrate how the rates of reverse TET and dynamic quenching can be ascertained independently based on determination of the sensitizer concentration that leads to the maximum upconversion quantum yield and of the experimentally-determined overall rate of sensitizer-dependent annihilator triplet decay.

Methods

Experimental

PtOEP, DPA, 1,3-diphenylisobenzofuran (DPBF), and dimethyl sulfide (DMS) were purchased from Sigma Aldrich and used as received. TTA-UC samples were prepared by mixing stock solutions of PtOEP and DPA in toluene. DMS (0.5 M) was added to each sample to scavenge the singlet oxygen that forms during photoexcitation. For optical measurements, TTA-UC samples were prepared in a 1 cm × 1 cm quartz cuvette (FireflySci). To ensure effective removal of oxygen, the TTA-UC samples were sealed with rubber septa and then purged with N₂ gas for 10 min. To ensure that the DMS had removed the majority of any remaining oxygen, we only recorded data after the steady-state upconverted fluorescence intensity had stabilized. The phosphorescence lifetime of DPA in our samples (*vide infra*) is well in line with literature values for freeze/pump/thawed samples.^{43,44} Taken together, these observations suggest that the oxygen removal in our samples was sufficient.

Upconversion data were collected at room temperature using a custom-designed setup that is shown schematically in Fig. S1 (ESI†). A 532-nm, continuous-wave (CW) laser



(Coherent, Verdi V12) served as the excitation source. For time-resolved emission experiments, TTA-UC samples were excited by a train of square pulses that was generated by an acousto-optic modulator. A function generator (WaveTek, Model 29) and a radio-frequency generator (IntraAction, Model ME) were used to control the repetition rate, amplitude, and duty cycle of the pulse train. Emission from the TTA-UC samples was projected onto a forward-biased Si photodiode (NewFocus, 2001-FS) after passing through a 532-nm notch filter and a bandpass filter designed to isolate either the phosphorescence from PtOEP or the upconverted fluorescence from DPA. The time-resolved emission decay was detected by the Si photodiode and collected by a digital oscilloscope (LeCroy 9400A).

For steady-state TTA-UC measurements, samples were excited by a spatially-filtered, 532-nm CW beam. The excitation power was controlled with a half-wave plate and a polarizing beam cube. The half-wave plate was mounted in a computer-controlled rotation stage (Aerotech, Ensemble Epaq). The excitation power was measured by directing a portion of the spatially-filtered excitation beam through a mechanical chopper (Maxxon DC Motors) and onto a calibrated Si photodiode (Thorlabs, DET36A2). Steady-state emission from the TTA-UC sample was collected and projected through a mechanical chopper (Maxxon DC Motors) onto a matched Si photodiode. Upconverted light was isolated with a ± 20 nm bandpass filter with its passband centered at 435 nm. Two digital lock-in amplifiers (Stanford Research Systems, DSP-SR810) were used to amplify the photodiode signals and to reject noise. Steady-state fluorescence measurements at various excitation powers were acquired in an automated fashion using a LabView program that rotated the half-wave plate by a 0.5° increment following each 2-s fluorescence-measurement interval. An entire set of upconverted fluorescence data typically consisted of data points collected at 32 different irradiances over a period of less than 70 s. Where needed, additional measurement intervals were added and a longer signal averaging time was used, resulting in an extended data-acquisition period of 135 s.

For spectral measurements, emission from the TTA-UC sample was coupled into a fiber-optic cable that was connected to a photospectrometer (Ocean Optics USB2000). A 532-nm notch filter was used to reject scattered excitation light. Emission ratios were calculated using the ratio of the “area under the curve” (AUC) of the emission spectra between 600 nm and 700 nm and the AUC of the emission spectra between 380 nm and 530 nm. These calculations were performed with MATLAB. To obtain emission ratio measurements at different excitation powers, a LabView program was used to rotate the half-wave plate by a 0.5° increment following each 4-s spectral measurement interval.

Kinetic modeling

The time-dependent concentrations of sensitizers in the lowest triplet state ($[^3S^*]$), annihilators in the emissive excited singlet state ($[^1A^*]$), annihilators in the lowest triplet state ($[^3A^*]$), and annihilators in a higher triplet state ($[^3A^{**}]$) were computed numerically using MATLAB. A simulation covering dynamics over a period of 400 μ s was performed with a fixed irradiation profile that consisted of a 200 μ s, constant-amplitude, 2 W cm $^{-2}$

pulse, followed by a 200 μ s “dark” period. $[^3S^*]_t$, $[^1A^*]_t$, $[^3A^*]_t$, and $[^3A^{**}]_t$ were computed with a time step of 1 ns. We note that the sensitizer singlet state was not modelled explicitly. Because ISC in most TTA-UC sensitizers, including PtOEP, takes place on a time scale that is far shorter than the time step of our simulations, the sensitizer triplet state was treated as being populated directly and losslessly *via* absorption of light from the ground state.

We now develop equations for $[^3S^*]_t$, $[^1A^*]_t$, $[^3A^*]_t$, and $[^3A^{**}]_t$. A detailed derivation of these equations is given in the ESI.† For $[^3S^*]_t$, we find

$$\begin{aligned} [^3S^*]_t &\approx [^3S^*]_{t-dt} \\ &+ dt \left(k_{\text{ex}} I [S]_0 + k_{\text{sens}}^R [S]_0 [^3A^*]_{t-dt} \right. \\ &+ k_{\text{FRET}} \left([S]_0 - [^3S^*]_{t-dt} \right) [^1A^*]_{t-dt} \\ &- [^3S^*]_{t-dt} \left(k_{\text{ex}} I + k_{\text{sens}}^R [^3A^*]_{t-dt} \right. \\ &+ k_{\text{FRET}} [^1A^*]_{t-dt} + k_{\text{sens}}^F \left([A]_0 - [^3A^*]_{t-dt} - [^3A^{**}]_{t-dt} \right) \\ &\left. \left. + k_{\text{T}}^S + k_{\text{ph}} + k_{\text{q}}^S \left([S]_0 - [^3S^*]_{t-dt} \right) + k_{\text{TTA}}^S [^3S^*]_{t-dt} \right) \right), \end{aligned} \quad (1)$$

where dt is the simulation time step. $[S]_0$ and $[A]_0$ represent the initial concentrations of sensitizers and annihilators in the TTA-UC system, respectively, and k_{ex} , k_{FRET} , k_{T}^S , k_{ph} , and k_{q}^S are the rate constants for excitation of ground-state sensitizers, FRET, intrinsic sensitizer triplet decay, sensitizer phosphorescence decay, and sensitizer triplet self-quenching, respectively. Additionally, k_{TTA}^S is the rate constant for TTA between two sensitizers, and k_{sens}^F and k_{sens}^R are the rate constants for triplet energy transfer from the sensitizer to the annihilator and from the annihilator to the sensitizer, respectively. For $[^3A^*]_t$ we find

$$\begin{aligned} [^3A^*]_t &\approx [^3A^*]_{t-dt} + dt \left(-2k_{\text{TTA}}^A [^3A^*]_{t-dt}^2 + k_{\text{IC}} [^3A^{**}]_{t-dt} \right. \\ &- k_{\text{T}}^A [^3A^*]_{t-dt} + k_{\text{sens}}^F \left([A]_0 - [^3A^*]_{t-dt} - [^3A^{**}]_{t-dt} \right) [^3S^*]_{t-dt} \\ &- k_{\text{sens}}^R [^3A^*]_{t-dt} \left([S]_0 - [^3S^*]_{t-dt} \right) \\ &\left. - k_{\text{q}}^A [^3A^*]_{t-dt} \left([S]_0 - [^3S^*]_{t-dt} \right) \right), \end{aligned} \quad (2)$$

where k_{TTA}^A is the rate constant for TTA between two annihilators, k_{T}^A is the rate constant for intrinsic annihilator triplet quenching, k_{IC} is the rate constant for internal conversion from the T_n state to the T_1 state of the annihilator, and k_{q}^A is the rate constant for dynamic quenching. For $[^1A^*]_t$ we find

$$\begin{aligned} [^1A^*]_t &\approx [^1A^*]_{t-dt} + dt \left(0.25k_{\text{TTA}}^A [^3A^*]_{t-dt}^2 + k_{\text{RISC}} [^3A^{**}]_{t-dt} \right. \\ &\left. - k_{\text{FRET}} \left([S]_0 - [^3S^*]_{t-dt} \right) [^1A^*]_{t-dt} - (k_{\text{n}} + k_{\text{NR}}^A) [^1A^*]_{t-dt} \right), \end{aligned} \quad (3)$$

where k_{n} and k_{NR}^A are the rate constants for the radiative and non-radiative decay of annihilator singlets, respectively, and



k_{RISC} is the rate constant for reverse ISC from the T_n state to the excited singlet state of the annihilator. For $[^3\text{A}^{**}]_t$ we find

$$[^3\text{A}^{**}]_t \approx [^3\text{A}^{**}]_{t-dt} + dt(0.75k_{\text{TTA}}^{\text{A}}[^3\text{A}^*]_{t-dt}^2 - (k_{\text{IC}} + k_{\text{RISC}})[^3\text{A}^{**}]_{t-dt}). \quad (4)$$

Finally, the upconverted fluorescence rate, $\text{Fl}(t)$, and the sensitizer phosphorescence rate, $\text{Ph}(t)$, were calculated using

$$\text{Fl}(t) = k_{\text{fl}}[^1\text{A}^*]_t \quad (5)$$

and

$$\text{Ph}(t) = k_{\text{ph}}[^3\text{S}^*]_t, \quad (6)$$

respectively. The initial conditions $[^3\text{S}^*]_0$, $[^3\text{A}^*]_0$, $[^1\text{A}^*]_0$, $[^3\text{A}^{**}]_0 = 0$ were used when solving these equations. The smaller the time step dt , the more accurate the results for $[^3\text{S}^*]_t$, $[^3\text{A}^*]_t$, $[^1\text{A}^*]_t$, $[^3\text{A}^{**}]_t$. A time step of 1 ns was chosen as a compromise between accuracy and efficiency.

The effective sensitizer and annihilator triplet lifetimes were calculated from the slopes of logarithms of the phosphorescence and fluorescence decays immediately after the excitation ceased,

$$\tau_{\text{S}} = \left(\frac{\log(k_{\text{ph}}[^3\text{S}^*]_{0.4\text{ms}}) - \log(k_{\text{ph}}[^3\text{S}^*]_{0.4\text{ms}-dt})}{dt} \right)^{-1} \quad (7)$$

and

$$\tau_{\text{A}} = \frac{1}{2} \left(\frac{\log(k_{\text{fl}}[^1\text{A}^*]_{0.4\text{ms}}) - \log(k_{\text{fl}}[^1\text{A}^*]_{0.4\text{ms}-dt})}{dt} \right)^{-1}, \quad (8)$$

respectively. The factor of $\frac{1}{2}$ in eqn (8) arises from the fact that upconverted fluorescence depends quadratically on the population of annihilator triplets.

To model the formation and decay of radiative excimers and exciplexes explicitly, the concentrations of two additional species were introduced. The time evolution of the concentration of sensitizer excimers ($[\text{S}^*\text{S}]_t$) is given as

$$[\text{S}^*\text{S}]_t \approx [\text{S}^*\text{S}]_{t-dt} + dt(k_{\text{q}}^{\text{S}}([S]_0 - [^3\text{S}^*]_{t-dt})[^3\text{S}^*]_{t-dt} - k_{\text{ph}}^{\text{excimer}}[\text{S}^*\text{S}]_{t-dt}), \quad (9)$$

where $k_{\text{ph}}^{\text{excimer}}$ is the rate constant for the radiative decay of sensitizer excimers. No non-radiative pathway was considered for the decay of sensitizer excimers. The rate of sensitizer excimer phosphorescence is then given by

$$\text{Ph}_{\text{excimer}}(t) = k_{\text{ph}}^{\text{excimer}}[\text{S}^*\text{S}]_t. \quad (10)$$

The time evolution of the concentration of exciplexes ($[\text{A}^*\text{S}]_t$) is given as

$$[\text{A}^*\text{S}]_t \approx [\text{A}^*\text{S}]_{t-dt} + dt(\delta \cdot k_{\text{q}}^{\text{A}}([S]_0 - [^3\text{S}^*]_{t-dt})[^3\text{A}^*]_{t-dt} - k_{\text{ph}}^{\text{ex}}[\text{A}^*\text{S}]_{t-dt}), \quad (11)$$

where δ is the fraction of dynamic quenching events that result in the formation of sensitizer–annihilator exciplexes and $k_{\text{ph}}^{\text{ex}}$ is the rate constant for the radiative decay of sensitizer–annihilator exciplexes. No non-radiative pathway was considered for the decay of sensitizer–annihilator exciplexes.

The steady-state phosphorescence and upconverted fluorescence rates were calculated by starting with the kinetic equations

$$\begin{aligned} \frac{d[^3\text{S}^*]_t}{dt} = & k_{\text{ex}}I([S]_0 - [^3\text{S}^*]_t) + k_{\text{sens}}^{\text{R}}([S]_0 - [^3\text{S}^*]_t)[^3\text{A}^*]_t \\ & + k_{\text{FRET}}([S]_0 - [^3\text{S}^*]_t)[^1\text{A}^*]_t \\ & - [^3\text{S}^*]_t(k_{\text{T}}^{\text{S}} + k_{\text{ph}} + k_{\text{q}}^{\text{S}}([S]_0 - [^3\text{S}^*]_t)) \\ & + k_{\text{TTA}}^{\text{S}}[^3\text{S}^*]_t + k_{\text{sens}}^{\text{F}}([A]_0 - [^3\text{A}^*]_t - [^3\text{A}^{**}]_t), \end{aligned} \quad (12)$$

$$\begin{aligned} \frac{d[^3\text{A}^*]_t}{dt} = & k_{\text{sens}}^{\text{F}}([A]_0 - [^3\text{A}^*]_t - [^1\text{A}^*]_t)[^3\text{S}^*]_t \\ & - k_{\text{sens}}^{\text{R}}[^3\text{A}^*]_t([S]_0 - [^3\text{S}^*]_t) - 2k_{\text{TTA}}^{\text{A}}[^3\text{A}^*]_t^2 - k_{\text{T}}^{\text{A}}[^3\text{A}^*]_t \\ & - k_{\text{q}}^{\text{A}}[^3\text{A}^*]_t([S]_0 - [^3\text{S}^*]_t) + k_{\text{IC}}[^3\text{A}^{**}]_t, \end{aligned} \quad (13)$$

$$\frac{d[^3\text{A}^{**}]_t}{dt} = 0.75k_{\text{TTA}}^{\text{A}}[^3\text{A}^*]_t^2 - (k_{\text{IC}} + k_{\text{RISC}})[^3\text{A}^{**}]_t, \quad (14)$$

and

$$\begin{aligned} \frac{d[^1\text{A}^*]_t}{dt} = & 0.25k_{\text{TTA}}^{\text{A}}[^3\text{A}^*]_t^2 + k_{\text{RISC}}[^3\text{A}^{**}]_t \\ & - k_{\text{FRET}}([S]_0 - [^3\text{S}^*]_t)[^1\text{A}^*]_t - (k_{\text{fl}} + k_{\text{NR}})[^1\text{A}^*]_t. \end{aligned} \quad (15)$$

eqn (12)–(15) are solved under steady-state conditions to obtain the steady-state concentration of sensitizer triplets ($[^3\text{S}^*]_{\text{ss}}$), annihilator triplets ($[^3\text{A}^*]_{\text{ss}}$), annihilator singlets ($[^1\text{A}^*]_{\text{ss}}$), and higher annihilator triplet states ($[^3\text{A}^{**}]_{\text{ss}}$). The rates of phosphorescence and upconverted fluorescence at steady state are given by

$$\text{Fl}_{\text{ss}} = k_{\text{fl}}[^1\text{A}^*]_{\text{ss}} \quad (16)$$

and

$$\text{Ph}_{\text{ss}} = k_{\text{ph}}[^3\text{S}^*]_{\text{ss}}, \quad (17)$$

respectively. The emission ratio at steady state is given by

$$R_{\text{em}} = \frac{\text{Ph}_{\text{ss}}}{\text{Fl}_{\text{ss}}} = \frac{k_{\text{ph}}[^3\text{S}^*]_{\text{ss}}}{k_{\text{fl}}[^1\text{A}^*]_{\text{ss}}}. \quad (18)$$

The quantum yield of delayed phosphorescence from reverse TET ($\Phi_{\text{ph}}^{\text{R}}$) is given by

$$\Phi_{\text{ph}}^{\text{R}} = \frac{\int_{t=0.4\text{ms}}^{t=0\text{ms}} \left(k_{\text{sens}}^{\text{R}}[^3\text{A}^*]_{t'}[S]_{t'} \left(\frac{k_{\text{ph}}}{k_{\text{ph}} + k_{\text{sens}}^{\text{F}}[A]_{t'} + k_{\text{T}}^{\text{S}}} \right) \right) dt'}{\int_{t=0.4\text{ms}}^{t=0\text{ms}} \left(k_{\text{ex}}I[S]_{t'} \right) dt'} \cdot \frac{\int_{t=0.4\text{ms}}^{t=0\text{ms}} \left(k_{\text{ph}}[^3\text{S}^*]_{t'} \right) dt'}{\int_{t=0.2\text{ms}}^{t=0\text{ms}} \left(k_{\text{ex}}I[S]_{t'} \right) dt'}. \quad (19)$$

$[^3\text{A}^*]_t$, $[^3\text{S}^*]_t$, $[S]_t$, and $[A]_t$ were calculated numerically. Simulated irradiation of the TTA-UC sample occurred during the



first 0.2 ms. Therefore, the total number of photons consumed as a result of photoexcitation is given by

$$\int_{t=0\text{ms}}^{t=0.2\text{ms}} k_{\text{ex}} I[S]_t dt' \quad (20)$$

Density-functional-theory calculations

Density-functional-theory (DFT) calculations on DPA and DPBF in their lowest triplet states were performed using (u)B3LYP-d3/def2SVP, *i.e.*, the unrestricted B3LYP functional using Grimme's empirical dispersion correction⁴⁵ (d3) and the basis set of Weigend and Ahlrichs⁴⁶ (def2SVP). The vibrational frequencies obtained from the calculations on DPA were used to calculate the average energy in each mode *via* the equipartition theorem, which dictates that, for each mode,

$$\langle E_{\text{vib}} \rangle = \hbar\omega(1/(\exp(\hbar\omega/k_{\text{B}}T) - 1)). \quad (21)$$

Because the goal of these calculations was to determine the order of magnitude of the thermal vibrational energy, we did not include an anharmonic correction to the mode frequencies (which would increase the thermal vibrational energy) or attempt to use a more accurate method for treating the triplet state.

$$\frac{k_{\text{ph}} [^3\text{S}^*]_{\text{SS}}}{k_{\text{fl}} [^1\text{A}^*]_{\text{SS}}} = \frac{k_{\text{ph}}}{k_{\text{fl}}} \frac{[^3\text{S}^*]_{\text{SS}}}{\left(\frac{0.25k_{\text{TTA}}^{\text{A}}}{k_{\text{fl}} + k_{\text{NR}}} \left(\frac{k_{\text{T}}^{\text{A}} + k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}} - \sqrt{(k_{\text{T}}^{\text{A}} + k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}})^2 + 5k_{\text{sens}}^{\text{F}} [\text{A}]_0 [^3\text{S}^*]_{\text{SS}} k_{\text{TTA}}^{\text{A}} \left(1 + \frac{0.25k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}}}{k_{\text{fl}} + k_{\text{NR}}} \right)} \right)}{-2k_{\text{TTA}}^{\text{A}} \left(1.25 + \frac{0.25k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}}}{k_{\text{fl}} + k_{\text{NR}}} \right)} \right)^2} \quad (22)$$

Results and discussion

A summary of the kinetic processes that constitute our basic mass-conserving TTA-UC model is shown in Fig. 1. The basic model does not consider any UEL mechanisms other than the intrinsic decays of sensitizer and annihilator triplets and the non-radiative decay of annihilator singlets. The rate equations for $[^3\text{S}^*]_t$, $[^3\text{A}^*]_t$, $[^1\text{A}^*]_t$, and $[^3\text{A}^{**}]_t$ were presented previously.⁴²

Although our mass-conserving TTA-UC model provides valuable mechanistic insights into the TTA-UC process, the model does not predict that UEL is correlated with the sensitizer concentration.

Fig. 2a and b show that the experimental upconverted fluorescence intensity at any given value of the irradiance increases when the sensitizer concentration goes from 2.5 μM to 10 μM . However, at higher sensitizer concentrations, the upconverted fluorescence intensity at any given value of the irradiance decreases with increasing $[S]_0$. A high concentration of sensitizers therefore appears to limit the upconversion yield, presumably through mechanisms such as quenching of annihilator triplets, expenditure of sensitizer triplets through sensitizer TTA, parasitic absorption of upconverted emission, and FRET.

The emission ratio, eqn (18), allows us to differentiate between loss mechanisms that affect the yields of both sensitizer triplets and annihilator singlets upon photoexcitation on the one hand, and loss mechanisms that only impact the yield of annihilator singlets on the other. In the basic TTA-UC model, the expression for the emission ratio can be expanded as

In the low-irradiance regime, $[^3\text{S}^*]_{\text{SS}}$ is small, so the dominant term within the radicand in eqn (20) is k_{T}^{A} . It is also the case when $[^3\text{S}^*]_{\text{SS}}$ is small that

$$1.25 \gg \frac{0.25k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}}}{k_{\text{fl}} + k_{\text{NR}}} \quad (23)$$

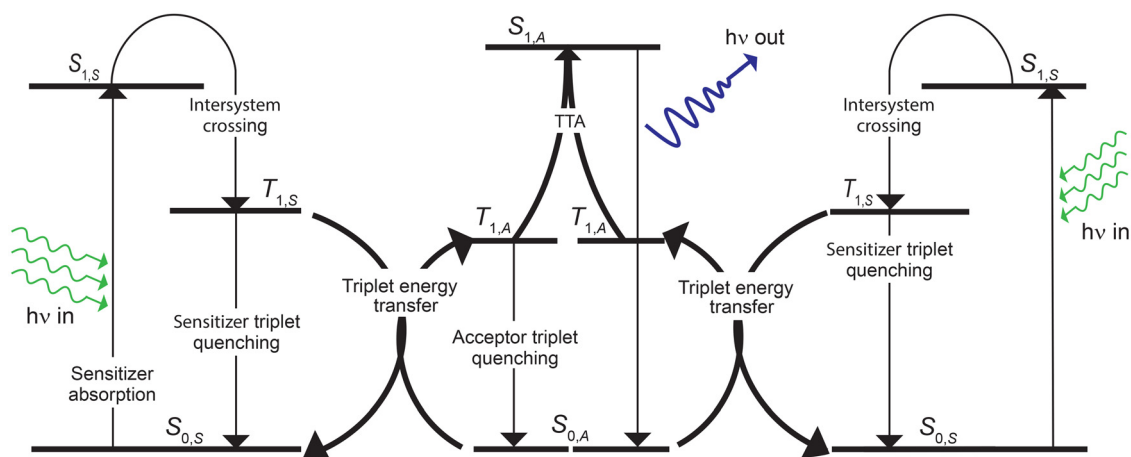


Fig. 1 A schematic illustrating the processes that are considered in the basic TTA-UC model.



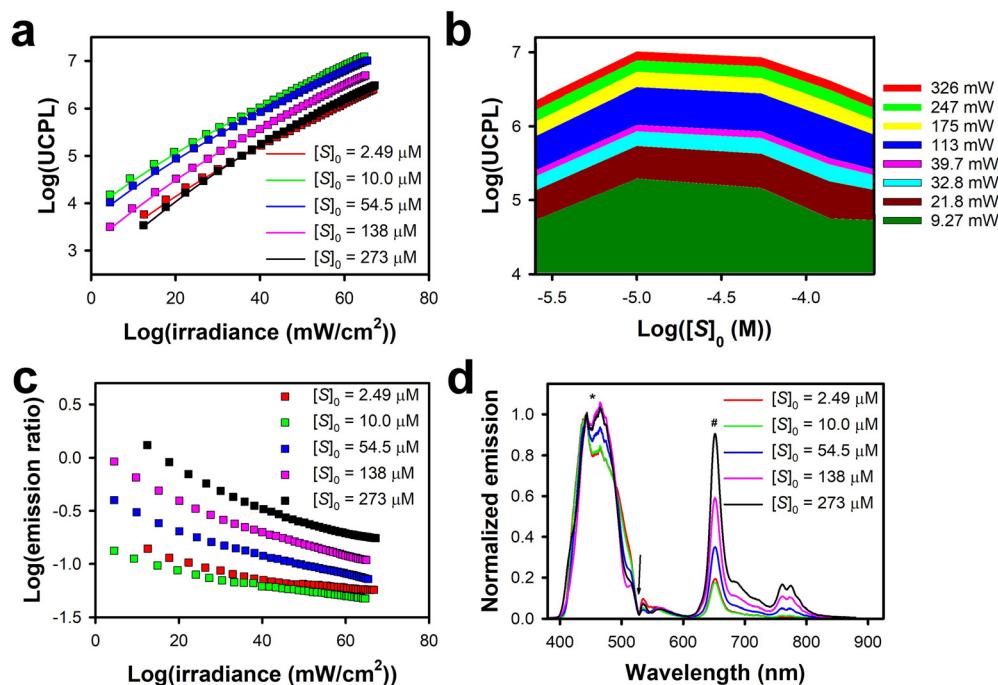


Fig. 2 Experimental TTA-UC data for PtOEP-DPA samples. (a) The dependence of the upconverted fluorescence intensity on irradiance. The data (squares) were fit with the basic mass-conserving TTA-UC model. (b) The dependence of the upconverted fluorescence intensity at specific excitation powers on the sensitizer concentration. (c) The dependence of the emission ratio on the irradiance. (d) Emission spectra of PtOEP-DPA samples normalized to the emission intensity at 445 nm. The peaks that originate from upconverted fluorescence are indicated by *, and the peaks that originate from sensitizer phosphorescence are indicated by #. The arrow indicates scattered excitation light and sample emission around 532 nm, which were blocked using a notch filter. The concentration of the annihilator was 1 mM.

Under these conditions eqn (22) can be simplified to

$$\begin{aligned} \frac{k_{\text{ph}} [^3\text{S}^*]_{\text{SS}}}{k_{\text{fl}} [^1\text{A}^*]_{\text{SS}}} &= \frac{k_{\text{ph}}}{k_{\text{fl}}} \\ &\times \frac{[^3\text{S}^*]_{\text{SS}}}{\frac{0.25k_{\text{TTA}}^{\text{A}} \left(\frac{k_{\text{T}}^{\text{A}} + k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}} - k_{\text{T}}^{\text{A}}}{-2.5k_{\text{TTA}}^{\text{A}}} \right)^2} + k_{\text{NR}}} \quad (24) \\ &= \frac{k_{\text{ph}}}{k_{\text{fl}}} \frac{[^3\text{S}^*]_{\text{SS}}}{\left(\frac{k_{\text{sens}}^{\text{F}} [^3\text{S}^*]_{\text{SS}}}{25(k_{\text{fl}} + k_{\text{NR}})} \right)^2} = \frac{k_{\text{ph}}}{k_{\text{fl}}} \frac{25(k_{\text{fl}} + k_{\text{NR}})}{k_{\text{sens}}^{\text{F}2} [^3\text{S}^*]_{\text{SS}}} \end{aligned}$$

Therefore, at low irradiances, the emission ratio decreases as $[^3\text{S}^*]_{\text{SS}}$ increases. Because $[^3\text{S}^*]_{\text{SS}}$ is proportional to I , the emission ratio is inversely proportional to I at low irradiances. As I increases, $[^1\text{A}^*]_{\text{SS}}$ becomes proportional to I until, at high enough irradiance, $[^1\text{A}^*]_{\text{SS}}$ ceases to increase. When $[^1\text{A}^*]_{\text{SS}}$ and $[^3\text{S}^*]_{\text{SS}}$ are both proportional to I , the emission ratio is independent of I . This trend in decreasing emission ratios with increasing I is consistent with the experimental TTA-UC data in Fig. 2c, which show that emission ratios decrease monotonically with I for all samples. Moreover, the rate of this decrease, *i.e.*, the slope in Fig. 2c, becomes smaller with increasing I until the emission ratios are almost independent of I . An increase in $[S]_0$ will result in an increase in $[^3\text{S}^*]_{\text{SS}}$, all other things being equal. Therefore, according to eqn (24), we can expect that

samples with higher sensitizer concentrations should exhibit lower emission ratios. This expectation is not consistent with the data in Fig. 2c. Our experiments show that when $[S]_0$ is within two orders of magnitude of $[A]_0$, the emission ratio increases with increasing $[S]_0$. We posit that this behavior is indicative of the existence of UEL mechanisms that quench excited annihilator molecules selectively while leaving the excited sensitizer population unaffected. Another possibility is that these UEL mechanisms enhance the yield of sensitizer triplets at the expense of excited annihilator molecules.

Fig. 2d shows emission spectra of TTA-UC samples with varying sensitizer concentrations. The spectra are normalized to the emission intensity at 445 nm. With increasing sensitizer concentration, the phosphorescence intensity increases relative to the intensity of the upconverted emission at 445 nm. Furthermore, an additional emission feature appears in the near-infrared (NIR) between 750 nm and 800 nm at higher sensitizer concentrations. This feature is not observed in the absence of the annihilator (Fig. S2a, ESI†). Therefore, we can rule out sensitizer-excimer emission and aggregation-induced emission as the cause of this NIR emission band. Radiative decay of exciplexes is a more likely explanation for the appearance of this feature. Indeed, we find that the integrated intensity of the NIR emission band has a dynamic dependence on excitation power, which is akin to the relationship between the upconverted fluorescence intensity and the excitation power (Fig. S2b, ESI†). Because the relationship between the integrated intensity of the



NIR emission band and the excitation power is linear, rather than quadratic, at low excitation powers, we conclude that the concentration of the NIR-emissive species is directly proportional to the concentration of annihilator triplets. The data in Fig. S2a (ESI†) also reveal the presence of a secondary sensitizer emission peak at 680 nm that is suppressed upon the addition of the annihilator. Upon close inspection (Fig. S2c, ESI†), it is apparent that in the absence of the annihilator, the intensity of this secondary sensitizer-emission peak increases with increasing sensitizer concentration. We therefore believe that the sensitizer-concentration dependence of the emission peak at 680 nm is likely indicative of the formation of PtOEP triplet excimers, which have a broader, and slightly red-shifted, emission profile as compared to that of the monomer (at ~ 650 nm).

Based on the above, we identify sensitizer-triplet excimer formation and quenching of annihilator triplets by ground-state sensitizer molecules to form exciplexes as two key UEL mechanisms in the PtOEP-DPA system. Additionally, because sensitizer phosphorescence is enhanced at the expense of upconverted fluorescence, we also consider the possibilities that FRET between the annihilator singlet state and the sensitizer singlet state and/or reverse TET are important UEL mechanisms. We additionally assess the effects of sensitizer TTA, a UEL mechanism that could be influential under circumstances in which the ratio between the concentrations of sensitizers and annihilators is high.

Fig. 3 shows a version of the Jablonski diagram from Fig. 1 in which the above-mentioned additional UEL mechanisms are included. Because the emissive annihilator singlet excited state is typically substantially higher in energy than the lowest sensitizer singlet excited state, FRET is assumed to be a unidirectional process from the annihilator to the sensitizer. Sensitizer TTA refers to the disproportionation of two sensitizer triplets, a process that ultimately results in the loss of one triplet, assuming a lossless ISC process should the annihilation generate an excited

singlet state. Sensitizer self-quenching refers to the sensitizer-triplet excimer-formation process. The rate and quantum yield of the radiative decay of sensitizer triplet excimers may differ from those of an isolated sensitizer in the triplet state. Reverse TET refers to the Dexter energy-transfer process from the annihilator triplet to the sensitizer triplet. Finally, dynamic quenching is a catch-all term for processes in which annihilator triplets are quenched by sensitizer molecules, including the formation of an exciplex between an annihilator triplet and a sensitizer molecule and SOC induced by heavy-metal-based sensitizer compounds. The list of UEL mechanisms that we consider here is not exhaustive. For example, the reabsorption of upconverted light by the sensitizer may lead to outcoupling losses in TTA-UC systems,⁴⁷ and a concomitant reduction in overall upconversion efficiency.⁷ Functionally, this UEL pathway is similar to FRET, in that a sensitizer singlet state is generated in conjunction with the loss of an annihilator singlet state. The total rate at which upconverted light is extracted from the TTA-UC system can be expressed as $\beta_{\text{ext}} k_{\text{fl}} [^1\text{A}^*]_{\text{SS}}$. β_{ext} is a branching ratio that determines the proportion of upconverted light that can be extracted from a TTA-UC system, and is given by $k_{\text{ext}} / (k_{\text{ext}} + k'_{\text{ex}} [\text{S}])$, where k_{ext} is the rate constant for the external extraction of upconverted photons from the TTA-UC system and k'_{ex} is the rate constant for the reabsorption of upconverted light by the sensitizer. When k'_{ex} is large and k_{ext} is small, β_{ext} becomes small and the reabsorption of upconverted light can emerge as a highly influential UEL mechanism. In reality, k_{ext} depends on a variety of factors, including the geometry of system, and therefore it is non-trivial to obtain a definitive estimate for β_{ext} . For those reasons, here we have opted to not study the impact of the reabsorption of upconverted light by the sensitizer on emission ratios or upconversion quantum yields. However, we do offer further insights into this parasitic reabsorption process in the ESI.† Other potential UEL mechanisms, such as absorption of

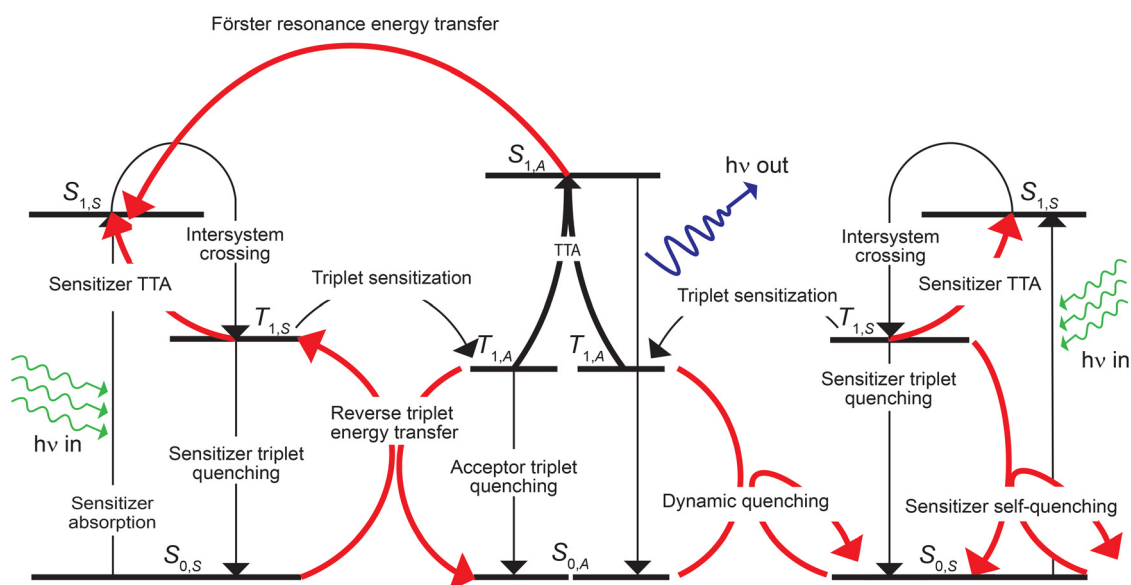


Fig. 3 A schematic illustrating the processes that are considered in the enhanced TTA-UC model, with the UEL pathways depicted as red arrows.



the upconverted light or of the excitation light by annihilators in the T_1 state and annihilator triplet-excimer formation, are not considered here, because the magnitudes of these mechanisms do not depend on the concentration of sensitizers.

Analytical, steady-state modelling was conducted to determine which of the aforementioned UEL mechanisms could replicate an upward trend in the emission ratio with increasing sensitizer concentration. The emission ratio at steady state was calculated from eqn (18). Fig. 4a shows that when k_{FRET} , k_{TTA}^S , k_q^S , k_{sens}^R , and k_q^A are all set to 0, the emission ratio at irradiances below 100 mW cm^{-2} is inversely proportional to $[S]_0$. A similar trend in the emission ratio is observed when $k_{\text{FRET}} = 2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and k_{TTA}^S , k_q^S , k_{sens}^R , and k_q^A are zero (Fig. 4b). It is apparent that if FRET is to be competitive with the radiative annihilator singlet-decay pathway, it must be the case that $k_{\text{FRET}}[S] \approx k_{\text{FRET}}[S]_0 > k_{\text{fl}}$. Typically, $[S]_0$ is orders of magnitude smaller than 1 M. Therefore, k_{FRET} must be several orders of magnitude larger than k_{fl} , which is usually on the order of 10^8 s^{-1} , for FRET to become an influential loss pathway. An inverse relationship between the emission ratio and $[S]_0$ persists at moderate-to-low irradiances in instances in which sensitizer TTA or sensitizer self-quenching are the only UEL loss pathways, barring intrinsic quenching effects (Fig. 4c and d, respectively). This result is not surprising, because both sensitizer TTA and sensitizer self-quenching decrease the upconversion efficiency by reducing the availability of sensitizer triplets.

Reverse TET is an interesting case. Fig. 4e demonstrates that when $k_{\text{sens}}^R = 2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and k_{TTA}^S , k_q^S , k_{FRET} and k_q^A are 0, the emission ratio decreases with an increase in $[S]_0$ from $10 \mu\text{M}$ to $100 \mu\text{M}$. However, a further increase in $[S]_0$ from $100 \mu\text{M}$ to 1 mM results in an increase in the emission ratio. There are two reasons why reverse TET is more likely to enhance the rate of

sensitizer phosphorescence at the expense of upconverted fluorescence in TTA-UC systems than is FRET. First, reverse TET is a competitive pathway for the depletion of annihilator triplets, as long as $k_{\text{sens}}^R[S] > k_{\text{T}}^A$ and $k_{\text{sens}}^R[S] > k_{\text{TTA}}^A[{}^3\text{A}^*]$. The rate constant k_{T}^A for annihilators such as DPA has been shown to be as low as 200 s^{-1} . Therefore, at low irradiances reverse TET can easily outcompete intrinsic annihilator triplet-quenching effects and TTA. At high irradiances, reverse TET can continue to outpace TTA, as long as the value of k_{sens}^R is on par with that of k_{TTA}^A and $[{}^3\text{A}^*]$ does not exceed $[S]$. Second, the upconverted fluorescence rate depends quadratically on $[{}^3\text{A}^*]$. Therefore, mechanisms that reduce the population of annihilator triplet states will have a stronger impact on emission ratios than do mechanisms that reduce the population of annihilator singlet states, such as FRET.

Finally, as seen in Fig. 4f, dynamic quenching on its own, when $k_q^A = 2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and k_{TTA}^S , k_q^S , k_{FRET} and k_{sens}^R are 0, can reverse the decreasing trend in emission ratios with increasing $[S]_0$. An increase in $[S]_0$ from $100 \mu\text{M}$ to 1 mM elicits a larger increase in the emission ratio than does an increase from $10 \mu\text{M}$ to $100 \mu\text{M}$. In a similar vein to reverse TET, dynamic quenching becomes a dominant depletion mechanism for annihilator triplets when $k_q^A[S] > k_{\text{T}}^A$ and $k_q^A[S] > k_{\text{TTA}}^A[{}^3\text{A}^*]$. Unlike reverse TET, however, dynamic quenching does not generate an excited molecule that can participate in the upconversion process or can phosphoresce. Therefore, when compared to reverse TET, dynamic quenching has a stronger effect on suppressing the rate of upconverted fluorescence, but does not enhance sensitizer phosphorescence. Of the five UEL mechanisms discussed here, only reverse TET and dynamic quenching are consistent with the experimentally observed trends in emission ratios with increasing $[S]_0$.

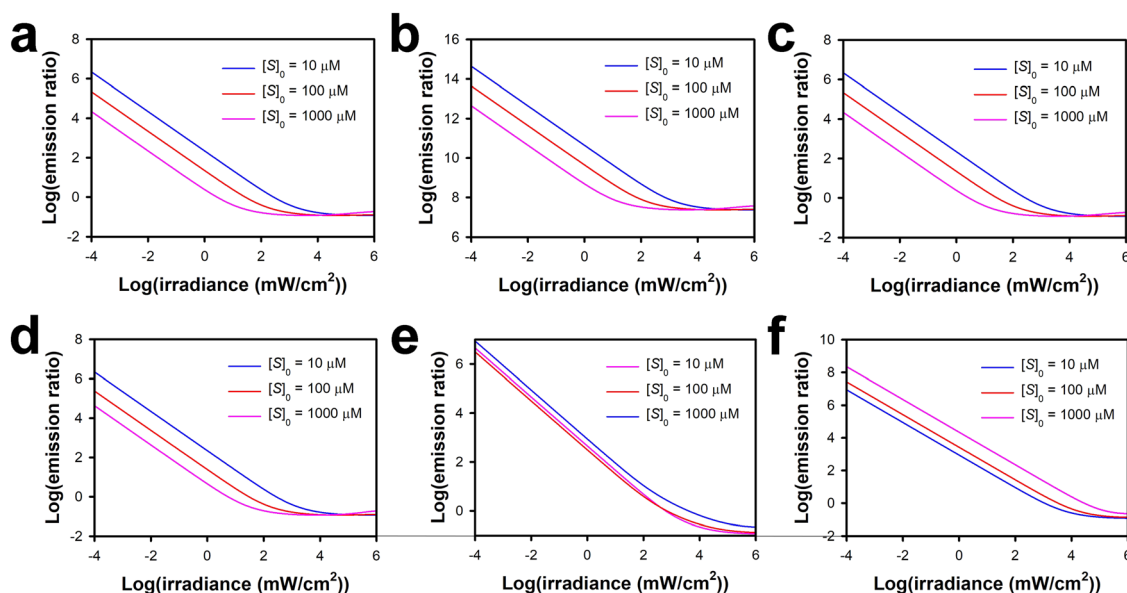


Fig. 4 Plots, based on kinetic modeling, of the dependence of the emission ratio on the irradiance for TTA-UC systems with UEL mechanisms including: (a) intrinsic quenching effects only; (b) FRET and intrinsic quenching effects only; (c) sensitizer TTA and intrinsic quenching effects only; (d) sensitizer self-quenching and intrinsic quenching effects only; (e) reverse TET and intrinsic quenching effects only; and (f) dynamic and intrinsic quenching effects only.



We first consider the behavior when only reverse TET is added to the basic model. In this situation, the effective annihilator-triplet lifetime, which is half the value of the slope of the log-log plots of normalized upconverted emission at time scales longer than ~ 50 μs , decreases with increasing sensitizer concentration (Fig. 5a). On the other hand, under the influence of reverse TET alone, the phosphorescence lifetime is initially dominated by the rapid forward TET process, and only on time scales longer than ~ 50 μs does the radiative decay of sensitizer triplets that have been repopulated *via* reverse TET appear as a second exponential component (Fig. 5b). The form of the slow decay component in Fig. 5b mimics the form of the upconverted-emission decays in Fig. 5a.

Fig. 5c and d show the results of kinetic modeling of the sensitizer phosphorescence and upconverted emission for systems in which dynamic quenching is the only UEL mechanism. Due to the dominance of dynamic quenching over TTA, no bimolecular decay component is visible in the upconverted-emission decays. However, the effective lifetime of annihilator triplets decreases rapidly with increasing sensitizer concentration. On the other hand, there is no change in the sensitizer-phosphorescence decays with increasing sensitizer concentration.

Fig. 5e demonstrates that when the effects of reverse TET and dynamic quenching are combined, the upconverted-emission decay at long times is dominated by the effects of dynamic quenching. The sensitizer-phosphorescence decays under the influence of both reverse TET and dynamic quenching resemble biexponential decays at all three sensitizer concentrations studied here (Fig. 5f). The form of the slow decay component in this case mimics that of the upconverted-emission decay curves in Fig. 5e.

The effects of reverse TET and dynamic quenching on the effective lifetime of the annihilator are most prominent when

$k_T^A < k_{\text{sens}}^R[S] < k_{\text{sens}}^F[A]$ or $k_T^A < k_q^A[S] < k_{\text{sens}}^F[A]$. Fig. S3a (ESI †) shows the dependence of the effective annihilator triplet lifetime on $\log(k_{\text{sens}}^R)$. This function has an inverse sigmoid shape. With increasing k_{sens}^R , the repopulation of annihilator triplets *via* forward TET becomes the rate-limiting step in the quenching of annihilator triplets *via* reverse TET, as shown in Fig. S3b (ESI †). Therefore, the upper asymptote in Fig. S3a and b (ESI †) is limited by the rate of intrinsic annihilator-triplet decay, and the lower asymptote is limited by the rate of forward TET. A similar relationship exists between both the effective sensitizer and annihilator triplet lifetimes and $\log([S]_0)$ (Fig. S3c and d, ESI †). Note that because the slow decay of the phosphorescence is a direct result of reverse TET, the effective lifetime of the sensitizer triplets is identical to that of annihilator triplets (*i.e.*, $\tau_A = \tau_S$). Experimentally, a straightforward method of establishing the influence of reverse TET and dynamic quenching is to determine the dependence of τ_A^{-1} on $[S]_0$. Fig. S4a (ESI †) illustrates the dependence of τ_A^{-1} on $[S]_0$ under different UEL mechanisms. When dynamic quenching is the sole UEL mechanism, τ_A^{-1} is linearly dependent on $[S]_0$, and the rate constant for dynamic quenching can be determined from the slope of the curve. However, with the inclusion of reverse TET, τ_A^{-1} tapers off with increasing $[S]_0$. Fig. S4b (ESI †) shows that when reverse TET is the only UEL mechanism, this tapering-off effect of τ_A^{-1} is more prominent for smaller values of $[A]_0$. With increasing $[A]_0/[S]_0$, the rate of forward TET is enhanced, thus decreasing τ_A^{-1} and diminishing the overall impact of reverse TET, in agreement with the experimental results of Meroni *et al.*³⁸ Meroni *et al.* also found that the improvement in the overall efficiency of triplet sensitization with an increased annihilator concentration reaches a plateau. However, our results indicate that the critical parameter is not $[S]_0$, but rather $[A]_0/[S]_0$. Indeed, for a given set of rate parameters, we find that

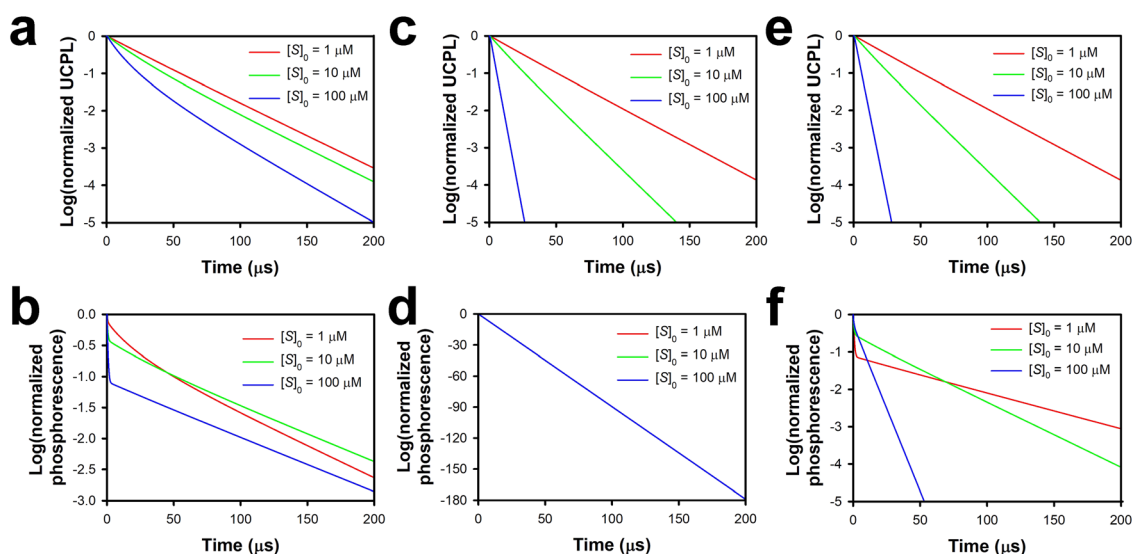


Fig. 5 Transient decays derived from kinetic models including: (a) upconverted fluorescence in the presence of reverse TET only; (b) phosphorescence in the presence of reverse TET only; (c) upconverted fluorescence in the presence of dynamic quenching only; (d) phosphorescence in the presence of dynamic quenching only; (e) upconverted fluorescence in the presence of both reverse TET and dynamic quenching; and (f) phosphorescence in the presence of both reverse TET and dynamic quenching.



a near universal relationship exists between τ_A^{-1} and $\log([A]_0/[S]_0)$, indicating that the effects of reverse TET on τ_A^{-1} are negated once $[A]_0/[S]_0$ exceeds a certain value. Fig. S5a and b (ESI†) show that in a TTA-UC system that possesses identical k_{sens}^R and k_{sens}^F of $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$, the effects of reverse TET on τ_S^{-1} and τ_A^{-1} are largely negated when the annihilator concentration is roughly two orders of magnitude larger than the sensitizer concentration.

We next compare the dependence of τ_A on $\log([S]_0)$ when reverse TET is the only UEL mechanism and when both reverse TET and dynamic quenching are present (Fig. S6a and b, respectively, ESI†). These figures also show the dependence of Φ_{ph}^R , the quantum yield for delayed phosphorescence from reverse TET measured over a 400- μs period, on $\log([S]_0)$. Φ_{ph}^R is the difference in the quantum yield for phosphorescence (*i.e.*, the number of emissive sensitizer triplets divided by the number of absorbed photons) with and without reverse TET. Fig. S6a (ESI†) shows that the growth in Φ_{ph}^R with increasing $[S]_0$ begins to accelerate when $[S]_0 > 10^{-6} \text{ M}$. The growth in Φ_{ph}^R becomes linear with respect to $\log([S]_0)$ when $\log([S]_0)$ is $\sim 10^{-5} \text{ M}$. With a further increase in $[S]_0$, Φ_{ph}^R reaches an asymptote. On the other hand, the decrease in τ_A with increasing $[S]_0$ accelerates when $k_{\text{sens}}^R[S]_0 \gg k_T^A$, a region in which the growth in Φ_{ph}^R with $\log([S]_0)$ has already begun to saturate. Fig. S6b (ESI†) demonstrates that dynamic quenching causes τ_A to begin to decrease at approximately the value of $[S]_0$ at which Φ_{ph}^R begins to increase, and that the behaviors of these two quantities roughly mirror one another. Once again, we find that dynamic quenching has a stronger effect on τ_A than does reverse TET. Moreover, dynamic quenching noticeably reduces Φ_{ph}^R . When $k_{\text{sens}}^R = 2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$, $k_q^A = 0 \text{ M}^{-1} \text{ s}^{-1}$, and $[S]_0 = 1 \text{ mM}$, Φ_{ph}^R is almost 90%, indicating that the vast majority of sensitizer phosphorescence originates from resensitized triplet states. The total phosphorescence quantum yield in this case is $\sim 19.0\%$. On the other hand, when k_{sens}^R and $[S]_0$ are maintained at their original values but k_q^A is increased to $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$, Φ_{ph}^R drops to just below 50%, indicating that a smaller proportion of the sensitizer phosphorescence can be attributed to reverse TET in this case.

$$F_{\text{SS}} = k_{\text{fl}}[^1\text{A}^*]_{\text{SS}} = 0.25 \frac{k_{\text{TTA}}^A k_{\text{fl}}}{k_{\text{fl}} + k_{\text{NR}}} \left(\frac{k_{\text{sens}}^F k_{\text{ex}} I [S]_0 [A]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \cdot \frac{1}{k_T^A + k_q^A \left([S]_0 - \frac{k_{\text{ex}} I [S]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \right)} \right)^2 \quad (29)$$

Now that we have established that an increase in the sensitizer concentration can lead to an increase in τ_A , and thereby limit the upconverted fluorescence yield and the upconversion quantum efficiency, we turn to the dependence of the upconverted quantum yield, Φ_{UC} , on the sensitizer concentration. Φ_{UC} is calculated under the steady-state approximation for a specific value of I , and is defined as

$$\Phi_{\text{UC}} = \frac{k_{\text{fl}}[^1\text{A}^*]_{\text{SS}}}{k_{\text{ex}} I [S]_{\text{SS}}} \quad (25)$$

In Fig. 6a–c, we demonstrate that Φ_{UC} possesses a Gaussian-like distribution as a function of $\log([S]_0)$. When $[S]_0$ is small,

Φ_{UC} increases with increasing $[S]_0$, because a larger value of $[S]_0$ leads to larger values of $[^3\text{S}^*]_{\text{SS}}$ and $[^3\text{A}^*]_{\text{SS}}$. A higher value of $[^3\text{A}^*]_{\text{SS}}$ implies that the bimolecular TTA process is favored over all other annihilator-triplet-depletion mechanisms, thereby increasing Φ_{UC} . However, with further increases in $[S]_0$, the effects of an increase in $[^3\text{A}^*]_{\text{SS}}$ are outweighed by an increase in the rates at which annihilator triplets undergo dynamic quenching and reverse TET. For pure dynamic quenching, an increase in $[S]_0$ is detrimental to Φ_{UC} when $k_q^A[S]_0 > k_T^A$.

When a TTA-UC system possesses a large enough pool of ground-state annihilator molecules that annihilator mass conservation can be ignored, $d[^3\text{A}^*]/dt$ can be expressed as

$$\frac{d[^3\text{A}^*]}{dt} = \frac{k_{\text{sens}}^F k_{\text{ex}} I [S]_0 [A]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} - 1.25 k_{\text{TTA}}^A [^3\text{A}^*]^2 - \left(k_T^A + k_q^A \left([S]_0 - \frac{k_{\text{ex}} I [S]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \right) \right) [^3\text{A}^*] \quad (26)$$

When the unimolecular decay terms are dominant, we can approximate that

$$\frac{d[^3\text{A}^*]}{dt} = \frac{k_{\text{sens}}^F k_{\text{ex}} I [S]_0 [A]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} - \left(k_T^A + k_q^A \left([S]_0 - \frac{k_{\text{ex}} I [S]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \right) \right) [^3\text{A}^*] \quad (27)$$

At steady state, $[^3\text{A}^*]_{\text{SS}}$ can then be expressed as

$$[^3\text{A}^*]_{\text{SS}} = \frac{k_{\text{sens}}^F k_{\text{ex}} I [S]_0 [A]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \times \frac{1}{k_T^A + k_q^A \left([S]_0 - \frac{k_{\text{ex}} I [S]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \right)} \quad (28)$$

and the rate of fluorescence becomes

When the bimolecular decay term is dominant, we can approximate that

$$\frac{d[^3\text{A}^*]}{dt} = \frac{k_{\text{sens}}^F k_{\text{ex}} I [S]_0 [A]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} - 1.25 k_{\text{TTA}}^A [^3\text{A}^*]^2 \quad (30)$$

$[^3\text{A}^*]_{\text{SS}}$ can then be expressed as

$$[^3\text{A}^*]_{\text{SS}} = \sqrt{\frac{k_{\text{sens}}^F k_{\text{ex}} I [S]_0 [A]_0}{k_{\text{ex}} I + k_{\text{sens}}^F [A]_0 + k_T^S} \cdot \frac{4}{5 k_{\text{TTA}}^A}} \quad (31)$$



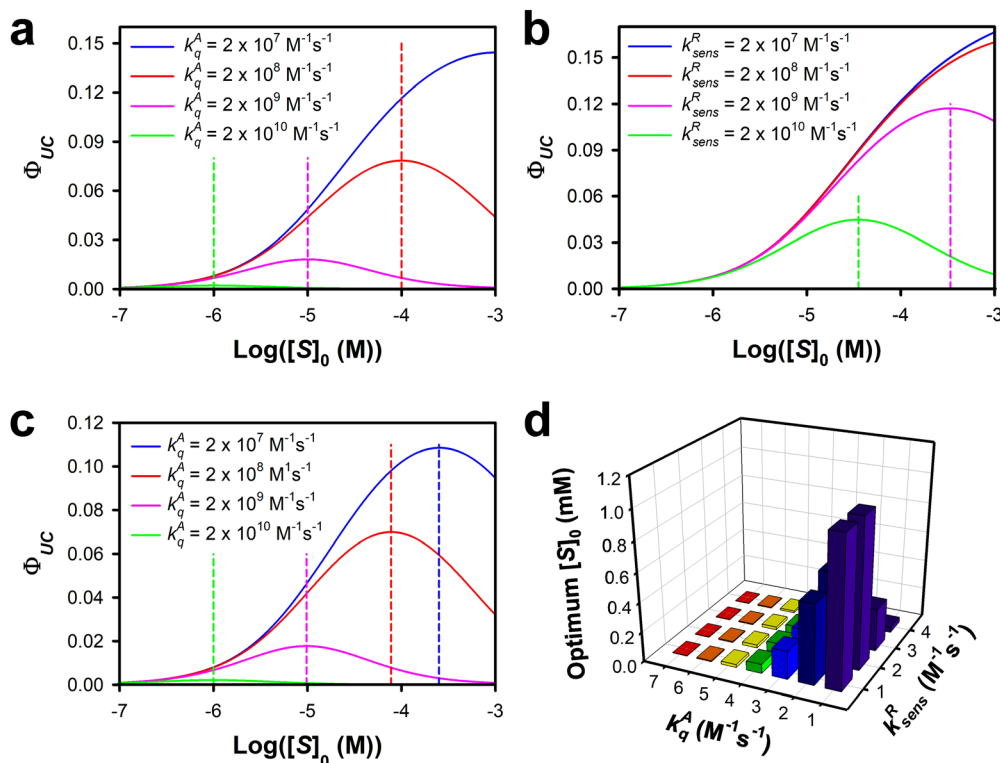


Fig. 6 Dependence of Φ_{UC} on $\log([S]_0)$ for TTA-UC systems with UEL mechanisms including: (a) dynamic quenching effects only, varying k_q^A ; (b) reverse TET only, varying k_{sens}^R ; and (c) both dynamic quenching and reverse TET, varying k_q^A and k_{sens}^R . (d) $[S]_{0,ideal}$ for TTA-UC systems with both dynamic quenching and reverse TET, varying k_q^A and k_{sens}^R . Ascending numeric labels for k_q^A from 1 through 7 indicate increasing values, by one order of magnitude each, from $2 \times 10^3 \text{ M}^{-1} \text{ s}^{-1}$ to $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$, and the ascending numeric labels for k_{sens}^R from 1 through 4 indicate increasing values, by one order of magnitude each, from $2 \times 10^4 \text{ M}^{-1} \text{ s}^{-1}$ to $2 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$. The dashed lines in (a)–(c) represent the concentrations at which the maximum value for Φ_{UC} is found.

and the rate of fluorescence is

$$F_{SS} = k_{\Pi}[^1A^*]_{SS} = 0.25 \frac{k_{TTA}^A k_{\Pi}}{k_{\Pi} + k_{NR}} \cdot \frac{k_{sens}^F k_{ex} I [S]_0 [A]_0}{k_{ex} I + k_{sens}^F [A]_0 + k_T^S} \cdot \frac{4}{5 k_{TTA}^A} \quad (32)$$

Setting eqn (29) equal to eqn (32), we find that

$$I_{th} = \frac{5(k_{ex} I + k_{sens}^F [A]_0 + k_T^S)}{4 k_{sens}^F k_{ex} I [S]_0 [A]_0 k_{TTA}^A} \cdot \left(k_T^A + k_q^A \left([S]_0 \left(1 - \frac{k_{ex} I}{k_{ex} I + k_{sens}^F [A]_0 + k_T^S} \right) \right) \right)^2 \quad (33)$$

Φ_{UC} for any TTA-UC system is higher when the bimolecular TTA process dominates over unimolecular annihilator triplet-decay processes. Therefore, a system with a lower I_{th} exhibits a higher Φ_{UC} . According to eqn (33), the critical condition for an increase in $[S]_0$ to be detrimental to Φ_{UC} is that $k_q^A [S]_0 \left(1 - \frac{k_{ex} I}{k_{ex} I + k_{sens}^F [A]_0 + k_T^S} \right) > k_T^A$. The value of $[S]_0$ that leads to the largest Φ_{UC} , for a TTA-UC system that is affected by dynamic quenching, which we denote $[S]_{0,ideal}$, is

$$[S]_{0,ideal} = \frac{k_T^A}{k_q^A \left(1 - \frac{k_{ex} I}{k_{ex} I + k_{sens}^F [A]_0 + k_T^S} \right)} \quad (34)$$

The ideal concentration of ground-state sensitizers can therefore be estimated from the value of k_T^A/k_q^A . Fig. 6c shows that with increasing k_q^A , the peak of a plot of Φ_{UC} as a function of $[S]_0$ (dashed lines) shifts towards smaller values of $[S]_0$. The magnitude of the peak value of Φ_{UC} also decreases with increasing k_q^A .

In the case of reverse TET, determining the value of $[S]_{0,ideal}$ becomes more complicated. Once again ignoring the effects of annihilator mass conservation, $d[^3A^*]/dt$ can be expressed as

$$\frac{d[^3A^*]}{dt} = \frac{k_{sens}^F (k_{ex} I + k_{sens}^R [^3A^*]) [S]_0 [A]_0}{k_{ex} I + k_{sens}^F [A]_0 + k_{sens}^R [^3A^*] + k_T^S} - 1.25 k_{TTA}^A [^3A^*]^2 - k_T^A [^3A^*] \quad (35)$$

Under the steady-state approximation, eqn (35) yields a quadratic expression for $[^3A^*]$ in the low-irradiance regime (in which the unimolecular decay term dominates), and a cubic expression for $[^3A^*]$ in the high-irradiance regime (in which the bimolecular decay term dominates). Although I_{th} can be obtained analytically from eqn (35), no analytical solution exists for $[S]_{0,ideal}$. Fig. 6b demonstrates that when k_{sens}^R is below $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and $[A]_0 = 1 \text{ mM}$, Φ_{UC} continues to increase with increasing $[S]_0$, even as $[A]_0/[S]_0$ reaches unity. When $k_{sens}^R = 2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and $[A]_0$ remains unchanged, a peak value of Φ_{UC} is reached when $[S]_0 \sim 3.1 \times 10^3 \text{ M}$. When k_{sens}^R is increased further to $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and $[A]_0$ remains unchanged, $[S]_{0,ideal}$ is near $3.2 \times 10^{-4} \text{ M}$. Fig. 6c and d illustrate the combination of the effects of reverse TET and



dynamic quenching on $[S]_{0,\text{ideal}}$. In Fig. 6c, k_{sens}^R was fixed at $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$ and k_q^A was varied from $2 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$ to $2 \times 10^{10} \text{ M}^{-1} \text{ s}^{-1}$. Dynamic quenching has its strongest effect on $[S]_{0,\text{ideal}}$ when k_q^R is on the same order of magnitude as k_q^A .

The intrinsic annihilator triplet-quenching rate has a prominent effect on Φ_{UC} and $[S]_{0,\text{ideal}}$. In the case of dynamic quenching, $[S]_{0,\text{ideal}}$ is given roughly by k_T^A/k_q^A . Fig. S7a (ESI†) shows that when k_T^A is set at $2 \times 10^2 \text{ s}^{-1}$ and k_q^A is fixed at $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$, $[S]_{0,\text{ideal}}$ is precisely 10^{-7} M . When k_T^A is increased by an order of magnitude, $[S]_{0,\text{ideal}}$ becomes 10^{-6} M . In contrast, with increasing k_T^A , Φ_{UC} decreases even as $[S]_{0,\text{ideal}}$ increases. In the case of reverse TET, $[S]_{0,\text{ideal}}$ increases proportionally with k_T^A , Φ_{UC} increases with increasing k_T^A , and there is a change in the shape of the distribution of Φ_{UC} . When k_T^A is small, the distribution in Φ_{UC} is broader than when k_T^A is large. Fig. S7b (ESI†) shows that when k_T^A is set at $2 \times 10^2 \text{ s}^{-1}$ and k_{sens}^R is fixed at $2 \times 10^9 \text{ M}^{-1} \text{ s}^{-1}$, there is a less than a 1% drop in Φ_{UC} as $[S]_0$ increases by one order of magnitude from $[S]_{0,\text{ideal}}$. On the other hand, when k_T^A is set at $2 \times 10^3 \text{ s}^{-1}$, there is a nearly 2% drop in Φ_{UC} as $[S]_0$ increases by an order of magnitude from $[S]_{0,\text{ideal}}$. The implication of this finding is that for systems that possess smaller values of k_T^A , the impact on Φ_{UC} due to deviations from $[S]_{0,\text{ideal}}$ is greatly reduced compared to what happens in systems with larger values of k_T^A . Φ_{UC} increases with increasing irradiance. However, $[S]_{0,\text{ideal}}$ is largely independent of I . Fig. S7c (ESI†) demonstrates that even under varying conditions, $[S]_{0,\text{ideal}}$ is independent of I .

Spin statistics dictate that for every excited singlet state that is populated *via* TTA, a higher triplet state and a quintuplet state should be populated as well. Typically, the quintuplet states are energetically inaccessible to the TTA pair. However, reverse ISC from a higher triplet state to the excited singlet state is possible. The effects of RISC can be captured by a branching ratio, β_{RISC} , which is given by

$$\beta_{\text{RISC}} = \frac{k_{\text{RISC}}}{k_{\text{RISC}} + k_{\text{IC}}} \quad (36)$$

Here, the rate constant k_{RISC} governs the rate at which RISC occurs between the higher triplet state and the emissive excited singlet state.

The maximum theoretical value for Φ_{UC} , $\Phi_{\text{UC,max}}$, is dependent on β_{RISC} *via*

$$\Phi_{\text{UC,max}} = \frac{0.25 + 0.75\beta_{\text{RISC}}}{1.75 + 0.75\beta_{\text{RISC}}} \quad (37)$$

We investigated whether delayed upconverted emission *via* reverse ISC from higher triplet states could alter our analysis of $[S]_{0,\text{ideal}}$. Because RISC between higher triplet states and excited singlet states in the annihilator affects only the total yield of singlets following a TTA event, β_{RISC} would not affect the impact of reverse TET or dynamic quenching on τ_A , F_{SS} , or Φ_{UC} . Indeed, in our analysis of the effects of reverse TET and dynamic quenching, we find that β_{RISC} affects the magnitude of Φ_{UC} , but does not affect $[S]_{0,\text{ideal}}$ (Fig. S7d, ESI†).

To assess the impacts of dynamic quenching and reverse TET on the model PtOEP-DPA upconversion system, we conducted transient photoluminescence experiments. The upconverted

fluorescence decay of the PtOEP/DPA system in deaerated toluene is shown in Fig. 7a. Annihilator-singlet decay occurs on a time scale of several ns, and does not limit the rate of the fluorescence decay. Therefore, the data in Fig. 7a must reflect the normalized logarithmic decay of $[^3\text{A}^*]^2$. A function of the form

$$F(t) \approx \left(\alpha \frac{1 - \beta}{\exp\left(\frac{t}{\tau_A}\right) - \beta'} \right)^2 \quad (38)$$

was used to fit the fluorescence decays. In eqn (38), α is a proportionality constant and β is a constant that describes the fraction of annihilator triplets that decay through bimolecular channels. Eqn (38) was adapted from Edhborg *et al.*, whose β' is identical to β .⁴⁸ However, to obtain the best fit to our data, β' must be slightly larger than β . We believe that the need for using a different value in the denominator arises from the fact that in the approximation used by Edhborg *et al.*, no new annihilator triplet states are generated after irradiation ceases, *i.e.* their kinetic equation contains only loss terms for annihilator triplet states. However, there remain excited sensitizers when irradiation ceases that can generate additional annihilator triplet states *via* TET. The full kinetic expression does not have an analytical solution, but we find that the partially *ad hoc* eqn (38) provides better fits to our data than does the expression of Edhborg *et al.*

The most important fitting parameter in eqn (38) is τ_A . Unsurprisingly, we find the bimolecular component of the upconverted-fluorescence decay to be dominant when the initial concentration of the sensitizer is high. More interestingly, we find that an increase in the initial concentration of PtOEP from 2.5 μM to 273 μM is accompanied by a steady decrease in τ_A^{-1} . When the experimentally-extracted values of τ_A^{-1} are plotted as a function of $[S]_0$ (Fig. 7b), a linear relationship between τ_A^{-1} and $[S]_0$ is apparent. The slope of the best linear fit in Fig. 7b is $3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$, and the y-intercept is 312 s^{-1} . From the slope of the linear fit in Fig. 7b, we can estimate that $k_{\text{sens}}^R + k_q^A = 3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$, and from the y-intercept of the best linear fit in Fig. 7b, we estimate that $k_T^A = 312 \text{ s}^{-1}$. The experimentally determined value of k_T^A is likely an underestimate, given that τ_A^{-1} in the limit $[S]_0 \rightarrow 0$ is smaller than k_T^A according to our simulations. Our result for $k_{\text{sens}}^R + k_q^A$ is roughly an order of magnitude larger than the rate constant for dynamic quenching that was obtained by the Schmidt group.²⁴

To determine whether reverse TET takes place in the PtOEP-DPA system, we measured the sensitizer-phosphorescence decay of the samples for which the upconversion data are shown in Fig. 7a. It is evident that the phosphorescence decays in Fig. 7c are biphasic. There is a rapid decay of sensitizer phosphorescence that we ascribe to forward TET, as well as a slower, non-exponential decay component. The decay curves in Fig. 7a and c bear a strong degree of similarity. We fit the phosphorescence decays to

$$I_{\text{Ph}}(t) \approx \exp(-k_1 t) + \left(\alpha \frac{1 - \beta}{\exp\left(\frac{t}{\tau_P}\right) - \beta'} \right)^2, \quad (39)$$



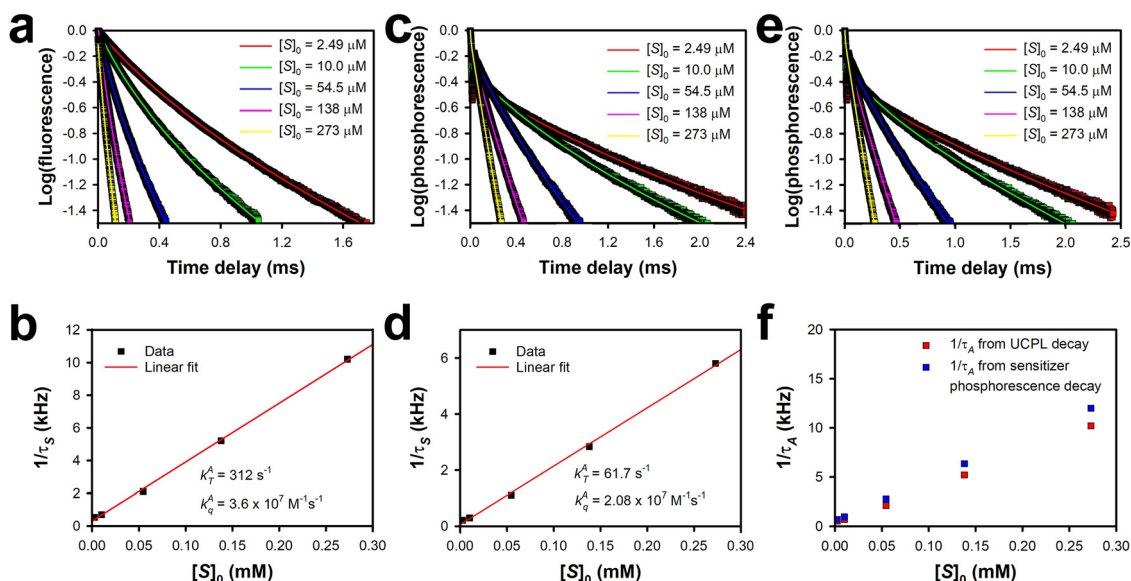


Fig. 7 Transient photoluminescence data. (a) Normalized upconverted fluorescence decay for TTA-UC samples with varying sensitizer concentrations. The data were fit to eqn (38). (b) Values of τ_A^{-1} extracted from the data in (a). The solid line is the best linear fit to the data. (c) Normalized phosphorescence decays fit to eqn (39). (d) Values of τ_S^{-1} extracted from the data in (c). The solid line is the best linear fit to the data. (e) Normalized phosphorescence decays fit to eqn (40). (f) Values of τ_A^{-1} extracted from (a) and (e). The concentration of the annihilator was 1 mM.

where k_1 is a rate constant corresponding to sensitizer triplet decay, which arises primarily from forward TET. The inverse lifetime of the long-lived component of phosphorescence decay, which we denote τ_P^{-1} , depends linearly on $[S]_0$, in analogy with the relationship between τ_A^{-1} and $[S]_0$. However, the values of τ_A^{-1} extracted from the experimental data are nearly twice as large as the corresponding values of τ_P^{-1} . When the phosphorescence-decay curves are fit instead with an equation of the form

$$\text{Ph}(t) \approx \exp(-k_1 t) + \left(\alpha \frac{1 - \beta}{\exp\left(\frac{t}{\tau_P}\right) - \beta'} \right)^1, \quad (40)$$

the experimentally extracted values of τ_P^{-1} are substantially closer to those of τ_A^{-1} (Fig. 7e and f). Therefore, the slow component in the phosphorescence decays must represent a static portion of the population of the annihilator triplet states, rather than the population of the annihilator singlet states. Accordingly, FRET can be ruled out as the origin of the slow decay component in the sensitizer-phosphorescence decays. Hence, reverse TET is the most probable source of this slow decay, because the rate at which reverse TET occurs must depend linearly on the population of annihilator triplets. Furthermore, the rate of forward TET is typically expected to be higher than the rate at which the sensitizer triplet manifold is repopulated *via* reverse TET. Therefore, the rate-limiting step in prolonged sensitizer emission should be the lifetime of the annihilator triplets, in agreement with our experimental observations.

It is natural to question why reverse TET from DPA to PtOEP might occur in the first place, given that it is generally accepted that an energy difference of ~ 0.14 eV exists between the energies of the triplet states of the two molecules (~ 1.91 eV and ~ 1.77 eV for PtOEP and DPA, respectively).^{41,49–51} The

triplet energy of PtOEP is commonly determined from a phosphorescence peak at ~ 650 nm.^{18,51–53} The triplet energy of DPA that is cited most often was determined from direct singlet-triplet absorption experiments in chloroform.⁴⁹ Given the uncertainty inherent in these measurements, it is certainly possible that the energy difference between the triplet states of PtOEP and DPA is smaller than the commonly accepted value.

The use of pure electronic energies, as opposed to vibronic energies, to determine the likelihood of triplet-energy transfer can be misleading. For instance, it has been shown that triplet sensitization with a large energy gap can lead to vibrational excitation in the triplet state of the acceptor molecule.⁵⁴ Detailed balance implies that the opposite process can also occur, *i.e.*, a vibrationally excited “acceptor” molecule may be more likely to undergo reverse TET to a “donor” molecule. To assess this possibility, we performed DFT calculations on the lowest triplet state of DPA to determine the frequencies of its vibrational modes. Accordingly, we can estimate the average amount of vibrational energy at room temperature. Given the relatively large size of DPA, it is not surprising that this average energy comes out to be 0.46 eV, which is more than three times the gap between the triplet energies of PtOEP and DPA. PtOEP is also a large molecule that has floppy pendant groups, and so should have an even larger average thermal vibrational energy than does DPA. This factor also works in favor of reverse TET, in that vibrations that are populated in the electronic ground state of PtOEP need not be populated following reverse TET, effectively lowering the energy gap between the singlet and triplet states in this molecule. The rate of Dexter transfer between two species is related to the integral of the product of the normalized singlet-triplet absorption spectrum of the acceptor (PtOEP for reverse TET in our case) and the phosphorescence spectrum



of the donor (DPA for reverse TET in our case),⁵⁵ so we can think of the thermally-populated vibrations as creating hot bands in these spectra. Therefore, only thermally-populated, Franck–Condon-active modes of the donor and acceptor will help to promote reverse TET. Although it is not possible to make a quantitative estimate of the rate of reverse TET based on these arguments, it is clear that even if a small fraction of the thermally-populated vibrations in PtOEP and DPA are involved in a reverse TET transition, the 0.14 eV “barrier” can easily be overcome.

Changes in the conformation of the sensitizer or the annihilator that result from thermal fluctuations can also alter the driving force for TET substantially.^{56,57} For TTA-UC systems in which the triplet energy gap between the sensitizer and annihilator is small, endothermic reverse TET can be facilitated by small conformational changes that decrease the S_0 – T_1 energy gap. Computational work by Zapata *et al.* showed that in-plane and out-of-plane distortions in the geometry of porphyrin molecules can alter the S_0 – T_1 gap by as much as 0.15 eV at room temperature.⁵⁸ Moreover, Gray *et al.* showed that at room temperature, the S_0 – T_1 gap of DPA can fluctuate by $\pm 1k_B T$ as the orientations of the molecules' two phenyl rings change.⁴¹ In our case, such conformational changes may induce small changes in the S_0 – T_1 gaps of DPA and PtOEP molecules, thereby reducing the energy barrier to reverse TET by several $k_B T$ and subsequently increasing the rate constant for reverse TET by an order of magnitude or more.

Finally, it is important to understand that even when the rate constant for reverse TET is several orders of magnitude smaller than the diffusion-limited value of $\sim 10^9 \text{ M}^{-1} \text{ s}^{-1}$, $\Phi_{\text{ph}}^{\text{R}}$ may be large enough for the effects of reverse TET to be observed in the form of a slow decay component in sensitizer phosphorescence-decay curves. Critically, $\Phi_{\text{ph}}^{\text{R}}$ values increase exponentially as the magnitude of the product $k_{\text{sens}}^{\text{R}}[S]$ begins to exceed the rate constant for intrinsic annihilator triplet decay. We highlight this behavior in Fig. S6a (ESI†), in which $\Phi_{\text{ph}}^{\text{R}}$ remains close to 0 when $k_{\text{sens}}^{\text{R}}[S] \ll k_{\text{A}}^{\text{T}}$, but rises exponentially with increases in $[S]$. As $[S]$ rises to 10^{-6} M , $\Phi_{\text{ph}}^{\text{R}}$ grows to a value of 0.1, indicating that more than 10% of total sensitizer phosphorescence now arises from the decay of triplet states that are populated *via* reverse TET. In Fig. S6 (ESI†), $k_{\text{sens}}^{\text{R}}$ is $\sim 10^9 \text{ M}^{-1} \text{ s}^{-1}$, and k_{A}^{T} is $\sim 10^4 \text{ s}^{-1}$. In a more experimentally relevant scenario, k_{A}^{T} values may be as small as $\sim 10^2 \text{ s}^{-1}$. Therefore, $\Phi_{\text{ph}}^{\text{R}}$ values well in excess of 10% can easily be achieved even when reverse TET is energetically unfavorable and $k_{\text{sens}}^{\text{R}}$ is $\sim 10^7 \text{ M}^{-1} \text{ s}^{-1}$. When the effects of dynamic quenching are factored in, $\Phi_{\text{ph}}^{\text{R}}$ is smaller, yet remains above 10% for sensitizer concentrations in excess of 10^{-6} M (Fig. S6b, ESI†). In our case, we find that even if reverse TET only accounts for a fraction of the value of $k_{\text{sens}}^{\text{R}} + k_{\text{q}}^{\text{A}}$ ($3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$) that we obtained from transient photoluminescence studies, $\Phi_{\text{ph}}^{\text{R}}$ should be large enough to lead to the observation of delayed sensitizer phosphorescence.

We also consider the possibility that the slow component in the sensitizer phosphorescence-decay curves arises from exciplex emission. The rate of formation of sensitizer–annihilator exciplexes, a process that falls under the umbrella of dynamic

quenching, is linearly dependent on the concentration of annihilator triplets. In a scenario in which the overall rate constant for the radiative and nonradiative decay of the sensitizer–annihilator exciplexes exceeds the rate at which the exciplexes are formed, the combined decay of sensitizer phosphorescence and exciplex emission would be similar to the decay we observe experimentally. In Fig. S8a (ESI†), decays for the sum of sensitizer phosphorescence and exciplex emission were calculated for a variety of rate constants for the radiative decay of sensitizer–annihilator exciplexes ($k_{\text{ph}}^{\text{ex}}$). Reverse TET was not included in the model, and the emission quantum yield of sensitizer–annihilator exciplexes (Φ_{ex}) was assumed to be unity. When $k_{\text{ph}}^{\text{ex}}$ is 200 s^{-1} , a strong accumulation in the population of exciplexes is observed at long times, as evidenced by the growth in total emission even 0.2 ms after the excitation ceases. Only when the value of $k_{\text{ph}}^{\text{ex}}$ is sufficiently large do the total emission decays resemble the phosphorescence decays observed experimentally.

A second experimentally relevant scenario is that $\Phi_{\text{ex}} < 1$, but the sum of the radiative and nonradiative sensitizer–annihilator exciplex decay processes is sufficiently large to avoid an accumulation of exciplexes on the sub-ms time scale. However, a small Φ_{ex} would decrease the contribution of exciplex emission. Exciplex emission from DPA–PtOEP samples, as characterized by emission peaks in the 750 nm to 800 nm range, was suppressed completely by the addition of DPBF (Fig. S8b, ESI†). DFT calculations revealed that the energy of the T_1 state of DPBF lies in the vicinity of 1.43 eV, which is well below the energy of DPA's T_1 state. Therefore, it is not surprising that the addition of DPBF to a sample containing DPA and PtOEP rapidly quenches the triplet states of DPA, thereby suppressing exciplex formation and subsequent emission. However, a slow bimolecular component in the sensitizer–phosphorescence decay is still observed for a TTA-UC sample containing DPBF, DPA, and PtOEP, despite the complete absence of exciplex emission from this sample (Fig. S8c, ESI†). For reference, no slow component could be identified in the sensitizer–phosphorescence decay for a TTA-UC sample containing only DPBF and PtOEP. Therefore, from Fig. S8b and c (ESI†) it is evident that the slow component that we observe in the phosphorescence decays in Fig. 7 cannot be attributed solely to exciplex emission, and must instead arise in large part from reverse TET.

We can conceive of only one scenario involving excimers in which the radiative decay of sensitizer triplet excimers results in the nonexponential decay of sensitizer emission. In the presence of the annihilator, the rate of forward TET would need to exceed the rate of sensitizer–excimer formation, and of all other sensitizer triplet-depletion mechanisms. Therefore, a biexponential decay of sensitizer emission, without any bimolecular decay features, would result when the rate of excimer decay, including all radiative and nonradiative pathways, is less than the rate of forward TET (Fig. S8d, ESI†). However, in this scenario, the lifetime of the delayed excimer emission would be independent of the concentration of sensitizer molecules. Therefore, we conclude that sensitizer excimer emission cannot be the origin of the slow component observed in the phosphorescence decays.



Having determined the sum of the rate constants for the sensitizer-dependent quenching processes from the slope of the linear fit to Fig. 7b, we now turn to determining the rate constants for reverse TET and dynamic quenching. We demonstrate that with knowledge of $[S]_{0,\text{ideal}}$ and $k_{\text{sens}}^R + k_q^A$, we can estimate k_{sens}^R and k_q^A . Fig. 8a shows the expected value of Φ_{UC} as a function of $[S]_0$ for two cases, one in which k_q^A is equal to the slope of the linear fit to Fig. 7b ($3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$) and k_{sens}^R is zero, and another in which k_q^A is zero and k_{sens}^R is equal to the slope of the linear fit to Fig. 7b ($3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$). In the first case, we find that $[S]_{0,\text{ideal}} \sim 10^{-5} \text{ M}$, which is close to the lower limit of $[S]_{0,\text{ideal}}$ that is given by $k_T^A/k_q^A = 8.64 \times 10^{-6} \text{ M}$. In the second case, $[S]_{0,\text{ideal}}$ is roughly $3.1 \times 10^{-4} \text{ M}$. Therefore, for the given set of system parameters, including the experimentally obtained values of k_T^A and $k_q^A + k_{\text{sens}}^R$, we find that $8.64 \times 10^{-6} \text{ M} < [S]_{0,\text{ideal}} < 3.1 \times 10^{-4} \text{ M}$. Fig. 8b shows $[S]_{0,\text{ideal}}$ for different combinations of k_{sens}^R and k_q^A , with the constraint that $k_q^A + k_{\text{sens}}^R = 3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$. Experimentally, $[S]_{0,\text{ideal}}$ can be estimated from the dependence of Φ_{UC} on $[S]_0$. Here, Φ_{UC} can be obtained experimentally at any value of the irradiance, as long as the irradiance at which Φ_{UC} is measured is unchanged for all samples with different $[S]_0$. As an example, if $[S]_{0,\text{ideal}}$ were to be estimated as $1 \times 10^{-5} \text{ M}$, $k_q^A \sim 2.5 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$, which would mean that $k_{\text{sens}}^R \sim 1.1 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$. With $k_{\text{sens}}^R = 1.1 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$, $k_q^A = 2.5 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$ and $k_T^A = 312 \text{ s}^{-1}$, we calculate Φ_{ph}^R to be 0.67% when $[S]_0 = 10^{-5} \text{ M}$. When $[S]_0 = 10^{-4} \text{ M}$, Φ_{ph}^R increases to 1.92%. Finally, when $[S]_0$ is increased to be on par with $[A]_0$, 1 mM, Φ_{ph}^R increases to 5.15%.

Conclusions

We have used new experimental approaches for the rapid collection of steady-state and time-resolved TTA-UC data to explore several possible mechanisms whereby an increased concentration of sensitizers might lead to UEL. The observation of an enhancement in sensitizer phosphorescence with increasing concentration of sensitizers, at the expense of upconverted fluorescence, led to the identification of reverse TET and dynamic quenching as the two most influential UEL mechanisms.

Spectral measurements on PtOEP-DPA samples revealed the emergence of a new NIR emission peak with increasing concentration of sensitizers; this peak was absent when no annihilator was present. Unlike the intensity of the principal phosphorescence peak centered at $\sim 650 \text{ nm}$, the intensity of the NIR emission peak is not proportional to the excitation power. Therefore, we believe that the NIR emission results from exciplex formation between annihilator triplets and sensitizers. These exciplexes constitute a potential source of dynamic quenching.

Transient photoluminescence measurements of PtOEP-DPA samples in toluene indicated that the effective lifetime of annihilator triplets decreases with increasing concentration of sensitizers, with an overall sensitizer-dependent-quenching rate constant of $3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$. Reverse TET was identified as the probable cause of the majority of the prolonged sensitizer emission, which had an effective lifetime on par with that of the

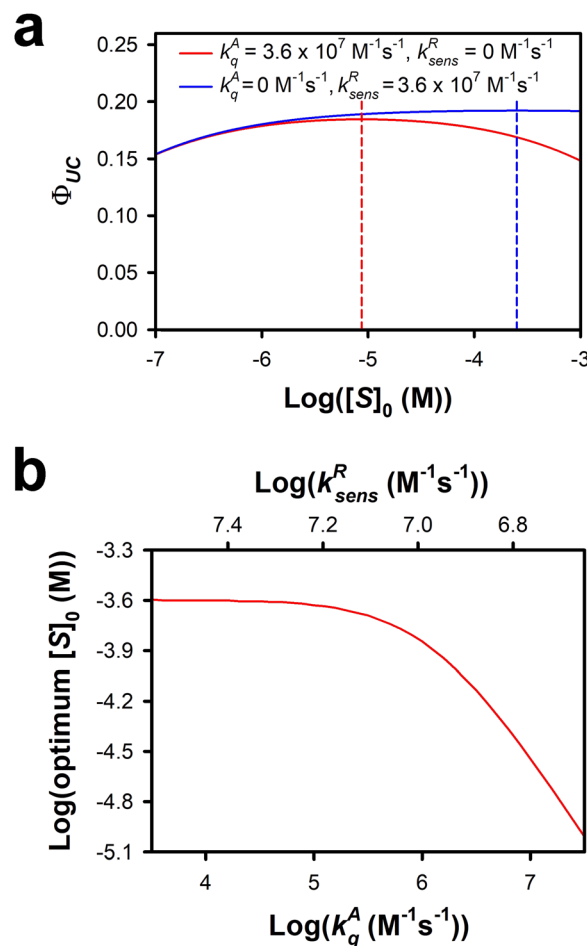


Fig. 8 Determining the rate constants for reverse TET and dynamic quenching. (a) Dependence of Φ_{UC} on $\log([S]_0)$ for TTA-UC systems with different values of k_{sens}^R and k_q^A . (b) Dependence of $[S]_{0,\text{ideal}}$ on k_q^A ; $k_q^A + k_{\text{sens}}^R$ was constrained to be $3.6 \times 10^7 \text{ M}^{-1} \text{ s}^{-1}$ and k_T^A was set to the experimentally-determined value of 312 s^{-1} .

annihilator triplets. Although at first glance reverse TET might appear unlikely to be an efficient UEL mechanism in the PtOEP-DPA system, we believe that thermal vibrational excitation in DPA and PtOEP, and conformation-dependent S_0 - T_1 energy gaps make the reverse TET process considerably more likely than is implied by the energies of the triplet-state origins in the equilibrium geometries of the molecules. The same phenomenon can occur in any TTA-UC system in which one or more of the components has a substantial number of low-frequency vibrational modes, and so we believe that reverse TET is likely to be an important UEL mechanism in many TTA-UC systems.

We also demonstrated that the rate constants for reverse TET and dynamic quenching can be determined given knowledge of $[S]_{0,\text{ideal}}$, $k_{\text{sens}}^R + k_q^A$, and k_T^A . We showed that $[S]_{0,\text{ideal}}$ can be determined from plots of the upconversion quantum yield as a function of the sensitizer concentration at constant irradiance, and that $k_{\text{sens}}^R + k_q^A$ and k_T^A can be determined from transient TTA-UC measurements performed at different sensitizer concentrations. This methodology should be applicable to a wide range of TTA-UC systems.



It will be of great interest to perform further experiments that can assess the role that thermal vibrational excitation plays in reverse TET in TTA-UC systems. One obvious approach is to perform temperature-dependent experiments in which the role of reverse TET can be assessed. However, a potentially confounding factor in such experiments is that other experimental parameters that are relevant to TTA-UC, such as the diffusion rate, are also sensitive to temperature.

Data availability

The data sets generated and/or analyzed in this study are available from the first/corresponding author on reasonable request.

Conflicts of interest

There are no conflicts of interest to declare.

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